

Notice of References Cited

Application/Control No.

09/786,809

Applicant(s)/Patent Under
Reexamination
ANDERL ET AL.

Examiner

David A. Zarneke

Art Unit

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-5,118,271 | 06-1992 | Baird et al. | 425/116 |
| | B | US-4,504,427 | 03-1985 | Moyer, Harold W. | 264/482 |
| | C | US-5,359,761 | 11-1994 | Whitson et al. | 29/883 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| * | N | EP 642165 | 03-1995 | EPO | | |
| * | O | JP 57 010955 | 05-1982 | JAPAN | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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